Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/633,273	YAN ET AL.
Examiner	Art Unit
Erick Rekstad	2621

SEARCHED				
Class	Subclass	Date	Examiner	
375	240.03	1/7/2006	ER	
382	266 268	1/7/2006	ER	
			·	
			,	
,	·			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
keyword search	1/7/2007	ER
IEEE search	1/7/2007	ER
Discussed case at QEM	1/4/2007	ER
·		